Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/044 105	CVED MA UD

nation SYED, MAJID

10/044,195 Examiner

Art Unit

Thuong (Tina) T. Nguyen

2155

SEARCHED					
Class	Subclass	Date	Examiner		
709	225,226, 231	3/17/2006	тн		
725	86	3/17/2006	TH		
			,		
			,		
		,			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
<u> </u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	3/17/2006	тн	
IEEE	3/17/2006	TH	
·			